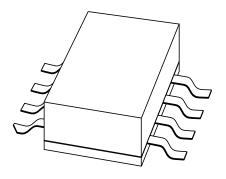
DISCRETE SEMICONDUCTORS

DATA SHEET



BLF404UHF power MOS transistor

Product specification Supersedes data of 1998 Jan 29 2003 Sep 26





UHF power MOS transistor

BLF404

FEATURES

- · High power gain
- · Easy power control
- · Gold metallization
- · Good thermal stability
- · Withstands full load mismatch
- Designed for broadband operation.

APPLICATIONS

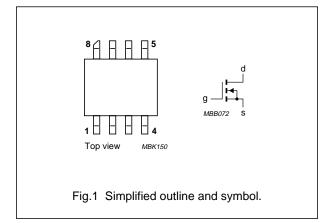
 Communication transmitters in the VHF/UHF range with a nominal supply voltage of 12.5 V.

DESCRIPTION

Silicon N-channel enhancement mode vertical D-MOS power transistor in an 8-lead SOT409A SMD package with a ceramic cap.

PINNING - SOT409A

PIN	DESCRIPTION
1, 8	source
2, 3	gate
4, 5	source
6, 7	drain



QUICK REFERENCE DATA

RF performance at $T_{mb} \le 60~^{\circ}C$ in a common source test circuit.

MODE OF OPERATION	f	V _{DS}	P _L	G _p	η _D
	(MHz)	(V)	(W)	(dB)	(%)
CW class-AB	500	12.5	4	≥10	≥50

CAUTION

This product is supplied in anti-static packing to prevent damage caused by electrostatic discharge during transport and handling. For further information, refer to Philips specs.: SNW-EQ-608, SNW-FQ-302A, and SNW-FQ-302B.

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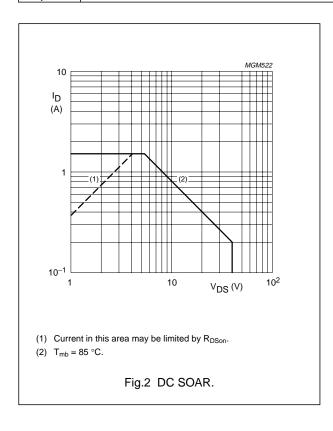
LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 60134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V _{DS}	drain-source voltage		_	40	V
V_{GS}	gate-source voltage		_	±20	V
I _D	drain current (DC)		_	1.5	А
P _{tot}	total power dissipation	T _{mb} ≤ 85 °C	_	8.3	W
T _{stg}	storage temperature		-65	+150	°C
Tj	junction temperature		_	200	°C

THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	CONDITIONS	VALUE	UNIT
R _{th i-mb}	thermal resistance from junction to mounting base	$T_{mb} \le 85 ^{\circ}C$, $P_{tot} = 8.3 \text{W}$	12.1	K/W



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CHARACTERISTICS

 $T_j = 25$ °C unless otherwise specified.

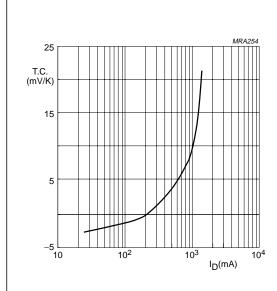
SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
V _{(BR)DSS}	drain-source breakdown voltage	V _{GS} = 0; I _D = 5 mA	40	_	_	V
V _{GSth}	gate-source threshold voltage	$I_D = 50 \text{ mA}; V_{DS} = 10 \text{ V}$	2	_	4.5	V
I _{DSS}	drain-source leakage current	V _{GS} = 0; V _{DS} = 12.5 V	_	_	0.5	mA
I _{GSS}	gate-source leakage current	$V_{GS} = \pm 20 \text{ V}; V_{DS} = 0$	_	_	1	μΑ
I _{DSX}	on-state drain current	V _{GS} = 15 V; V _{DS} = 10 V	_	2.3	_	Α
R _{DSon}	drain-source on-state resistance	$I_D = 0.7 \text{ A}; V_{GS} = 15 \text{ V}$	_	1.8	2.7	Ω
9 _{fs}	forward transconductance	$I_D = 0.7 \text{ A}; V_{DS} = 10 \text{ V}$	200	270	_	mS
C _{is}	input capacitance	$V_{GS} = 0$; $V_{DS} = 12.5 \text{ V}$; $f = 1 \text{ MHz}$	_	14	_	pF
Cos	output capacitance	V _{GS} = 0; V _{DS} = 12.5 V; f = 1 MHz	_	17	_	pF
C _{rs}	feedback capacitance	V _{GS} = 0; V _{DS} = 12.5 V; f = 1 MHz	_	3	_	pF

V_{GS} group indicator

GROUP	LIMITS (V)		GROUP		NITS V)
	MIN.	MAX.		MIN.	MAX.
А	2.0	2.1	0	3.3	3.4
В	2.1	2.2	Р	3.4	3.5
С	2.2	2.3	Q	3.5	3.6
D	2.3	2.4	R	3.6	3.7
Е	2.4	2.5	S	3.7	3.8
F	2.5	2.6	Т	3.8	3.9
G	2.6	2.7	U	3.9	4.0
Н	2.7	2.8	V	4.0	4.1
J	2.8	2.9	W	4.1	4.2
K	2.9	3.0	Х	4.2	4.3
L	3.0	3.1	Y	4.3	4.4
М	3.1	3.2	Z	4.4	4.5
N	3.2	3.3			

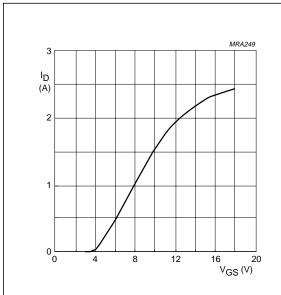
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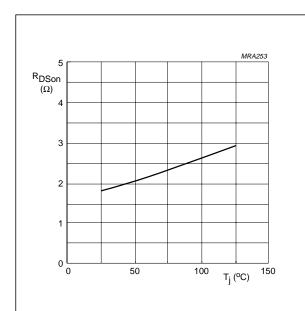
 $V_{DS} = 10 \text{ V}.$

Fig.3 Temperature coefficient of gate-source voltage as a function of drain current; typical values.



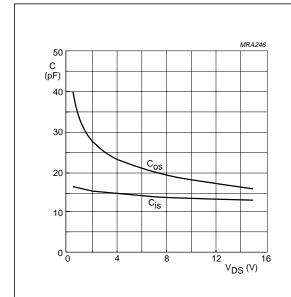
 $V_{DS} = 10 \text{ V}; T_j = 25 ^{\circ}\text{C}.$

Fig.4 Drain current as a function of gate-source voltage; typical values.



 $I_D = 0.7 \text{ A}; V_{GS} = 15 \text{ V}.$

Fig.5 Drain-source on-state resistance as a function of junction temperature; typical values.

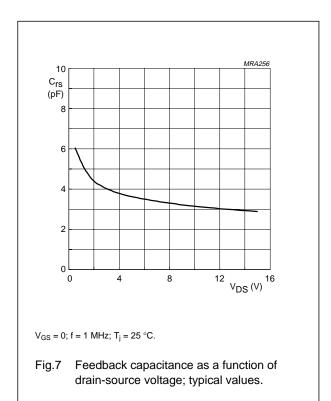


 $V_{GS} = 0$; f = 1 MHz; $T_j = 25$ °C.

Fig.6 Input and output capacitance as functions of drain-source voltage; typical values.

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APPLICATION INFORMATION

RF performance at $T_{mb} \le 60$ °C in a common source test circuit with the device soldered on a printed-circuit board with through metallized holes.

MODE OF OPERATION	f (MHz)	V _{DS} (V)	I _{DQ} (A)	P _L (W)	G _p (dB)	η _D (%)
CW, class-AB	500	12.5	50	4	≥10	≥50
					typ. 11.5	typ. 55

Ruggedness in class-AB operation

The BLF404 is capable of withstanding a load mismatch corresponding to VSWR = 10 : 1 through all phases under the following conditions: f = 500 MHz; $V_{DS} = 12.5$ V; $P_L = 4$ W; $T_{mb} \le 60$ °C.

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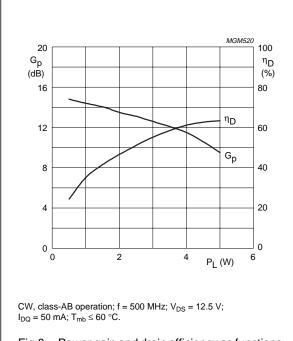


Fig.8 Power gain and drain efficiency as functions of load power; typical values.

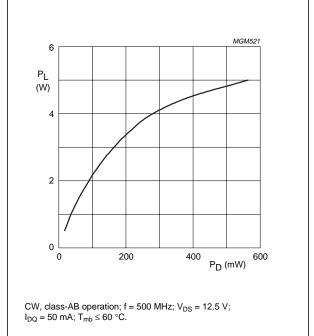
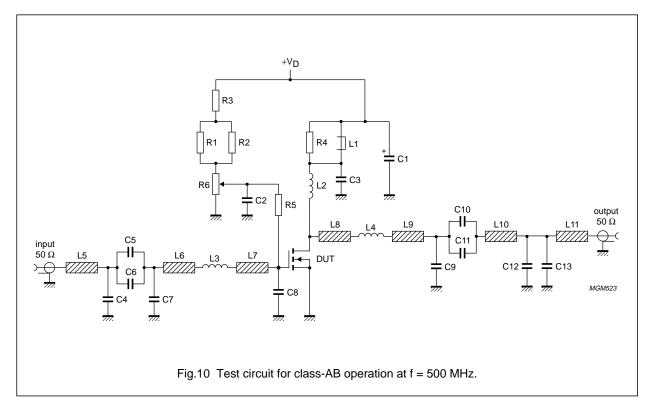


Fig.9 Load power as a function of drive power; typical values.



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List of components; see Figs 10 and 11.

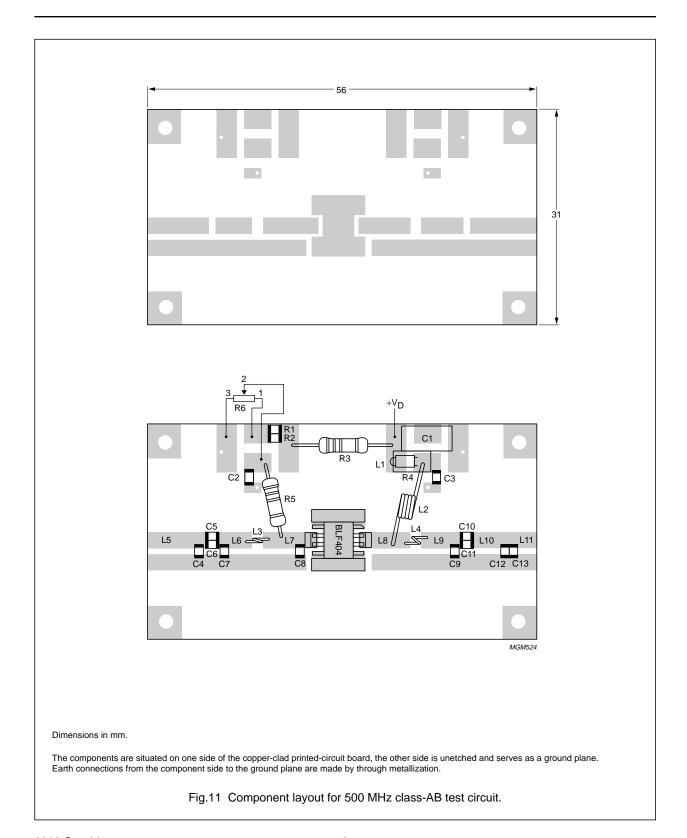
COMPONENT	DESCRIPTION	VALUE	DIMENSIONS	CATALOGUE NO.
C1	electrolytic capacitor	4.7 μF, 10 V		
C2, C3	multilayer ceramic chip capacitor	47 nF		
C4	multilayer ceramic chip capacitor; note 1	18 pF		
C5, C10	multilayer ceramic chip capacitor; note 1	180 pF		
C6, C11	multilayer ceramic chip capacitor; note 1	270 pF		
C7	multilayer ceramic chip capacitor; note 1	22 pF		
C8	multilayer ceramic chip capacitor; note 1	8.2 pF		
C9	multilayer ceramic chip capacitor; note 1	2.7 pF		
C12	multilayer ceramic chip capacitor; note 1	1.2 pF		
C13	multilayer ceramic chip capacitor; note 1	12 pF		
L1	2 turns 1 mm enamelled copper wire on a grade 4B1 Ferroxcube core		ext. dia. = 4.2 mm int. dia. = 2 mm length = 6 mm	
L2	3 turns 1 mm enamelled copper wire		int. dia. = 4.6 mm leads = 2 x 5 mm	
L3	bifilar coil		lead dia. = 0.8 mm	
L4	bifilar coil		lead dia. = 1 mm	
L5	stripline; note 2	50 Ω	8.8 × 2.38 mm	
L6	stripline; note 2	50 Ω	5.8 × 2.38 mm	
L7	stripline; note 2	50 Ω	6.8 × 2.38 mm	
L8	stripline; note 2	50 Ω	3.76 × 2.38 mm	
L9	stripline; note 2	50 Ω	5.8 × 2.38 mm	
L10	stripline; note 2	50 Ω	4.48 × 2.38 mm	
L11	stripline; note 2	50 Ω	3.13 × 2.38 mm	
R1, R2	SMD resistor	3.9 kΩ		
R3	metal film resistor	1 kΩ, 0.25 W		
R4	metal film resistor	22 Ω, 0.25 W		
R5	metal film resistor	10 kΩ, 0.25 W		
R6	potentiometer	10 kΩ		

Notes

- 1. American Technical Ceramics type 100A or capacitor of same quality.
- 2. The striplines are on a double copper-clad printed-circuit board, with DUROID dielectric (ϵ_r = 2.2); thickness 0.79 mm, thickness of the copper sheet 2 x 35 μ m.

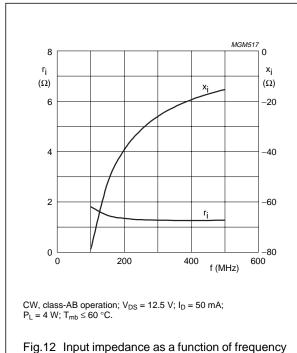
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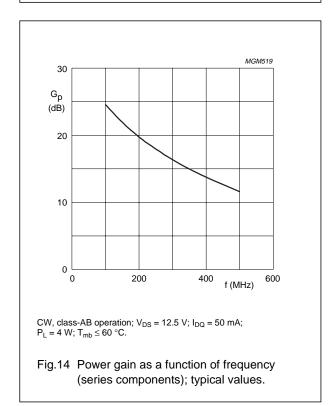
(series components); typical values.

 $\begin{array}{c} 16 \\ Z_L \\ (\Omega) \\ 12 \\ 8 \\ 4 \\ 0 \\ 0 \\ 200 \\ \end{array}$ R_L X_L X_L $A_{DS} = 12.5 \text{ V}; I_D = 50 \text{ mA}; P_L = 4 \text{ W}; T_{mb} \leq 60 \text{ °C}.$

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Fig.13 Load impedance as a function of frequency (series components); typical values.



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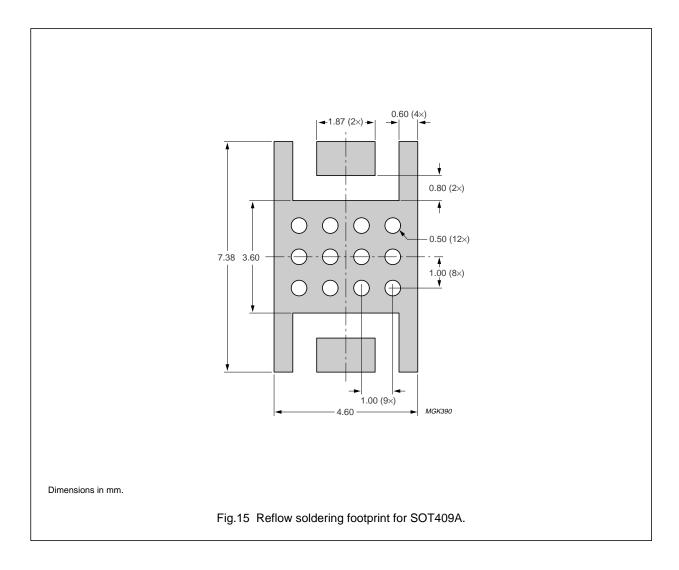
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MOUNTING RECOMMENDATIONS

Both the metallized ground plate and the device leads contribute to the heat flow. It is recommended that the transistor be mounted on a grounded metallized area of the printed-circuit board. This area should be of maximum 0.8 mm thickness and include at least 12 x 0.5 diameter through metallized holes filled with solder.

A thermal resistance $R_{th(mb-h)}$ of 5 K/W can be achieved if heatsink compound is applied when the transistor is mounted on the printed-circuit board.



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BLF404 scattering parameters

 V_{DS} = 12.5 V; I_{D} = 50 mA; note 1.

£ /MU=\	f (MHz)		(MHz) S ₁		s	21	S	12	s	22
i (IVITIZ)	s ₁₁	∠Φ	s ₂₁	∠Φ	s ₁₂	∠Φ	S ₂₂	∠Φ		
5	1.00	-5.2	12.97	176.0	0.01	86.0	0.96	-6.0		
10	0.99	-10.1	12.89	171.9	0.02	82.2	0.96	-12.0		
20	0.98	-20.6	12.61	164.1	0.03	74.8	0.95	-23.5		
30	0.96	-30.4	12.18	156.6	0.05	67.6	0.93	-34.7		
40	0.93	-39.6	11.62	149.6	0.06	60.9	0.91	-45.1		
50	0.89	-48.0	11.00	143.2	0.07	54.8	0.89	-54.7		
60	0.86	-55.8	10.37	137.4	0.08	49.4	0.87	-63.5		
70	0.83	-62.9	9.74	132.2	0.09	44.4	0.85	-71.4		
80	0.80	-69.4	9.15	127.5	0.10	40.1	0.83	-78.5		
90	0.78	-75.3	8.60	123.2	0.10	36.2	0.82	-84.8		
100	0.75	-80.7	8.08	119.3	0.10	32.7	0.80	-90.5		
125	0.71	-92.2	6.96	110.7	0.11	25.1	0.77	-102.6		
150	0.68	-101.4	6.03	103.9	0.12	19.1	0.76	-111.9		
175	0.66	-108.9	5.30	98.3	0.12	14.4	0.74	-119.2		
200	0.64	-115.2	4.73	93.2	0.12	10.2	0.74	-125.1		
250	0.63	-124.9	3.81	84.5	0.12	3.5	0.73	-134.1		
300	0.64	-132.5	3.19	77.4	0.12	-1.8	0.74	-140.5		
350	0.64	-138.6	2.70	71.2	0.11	-6.1	0.74	-145.3		
400	0.66	-143.8	2.34	65.7	0.11	-9.7	0.75	-149.1		
450	0.67	-148.4	2.03	60.5	0.10	-12.5	0.76	-152.4		
500	0.69	-152.6	1.80	56.0	0.09	-15.1	0.78	-155.2		
600	0.72	-160.2	1.44	47.7	0.08	-18.2	0.80	-159.9		
700	0.75	-167.1	1.18	40.4	0.07	-18.6	0.82	-163.9		
800	0.78	-173.6	0.99	34.4	0.05	-15.0	0.84	-167.5		
900	0.81	-179.8	0.84	29.2	0.04	-6.0	0.86	-170.7		
1000	0.83	174.3	0.73	25.1	0.04	9.9	0.88	-173.6		

Note

For more extensive s-parameters see internet: http://www.semiconductors.philips.com/markets/communications/wirelesscommunications/broadcast

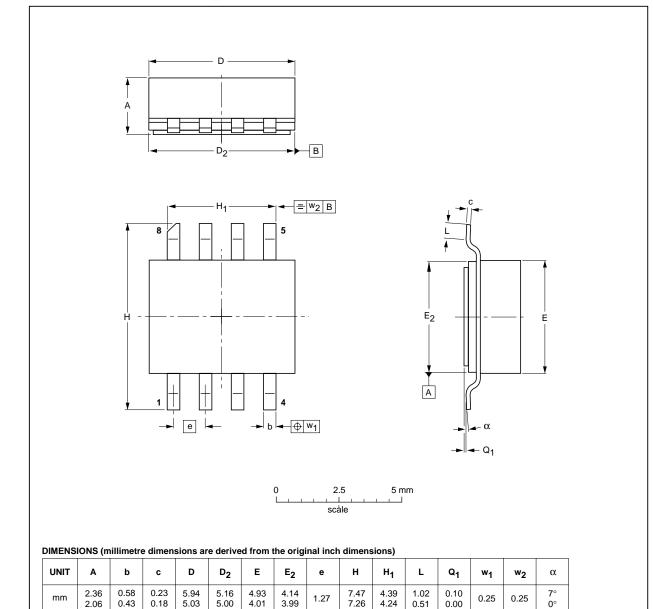
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PACKAGE OUTLINE

Ceramic surface mounted package; 8 leads

SOT409A



OUTLINE		REFERENCES			EUROPEAN	ISSUE DATE
VERSION	IEC	JEDEC	EIAJ		PROJECTION	ISSUE DATE
SOT409A						98-01-27

0.050

0.173

0.167

0.286

0.040

0.004

0.010

0.010

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0.093

0.023

0.017

0.009

0.007

0.234

0.198

0.203

0.197

0.194

0.158

0.163

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